Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/617,690	TANAKA ET AL.		
Examiner	Art Unit		
Jack Chiang	2642		

SEARCHED							
Class	Subclass	Date	Examiner				
379	433.13	8/11/2005	<i>Y</i> ,				
455	575.3						
455	575.1						
348	340	4	4				

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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